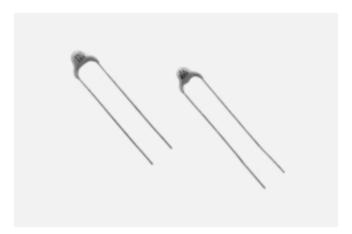
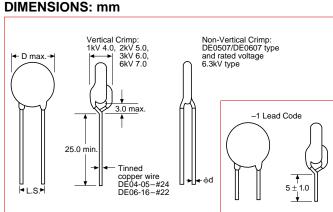
LEADED CAPACITORS, NETWORKS & HV CAPACITORS MEDIUM VOLTAGE CAPACITORS

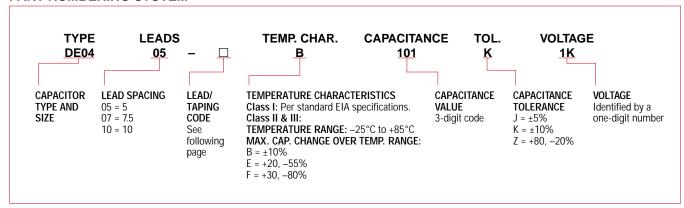
1kV to 6kVDC E.I.A. CLASS II & III



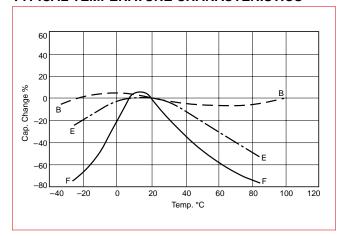




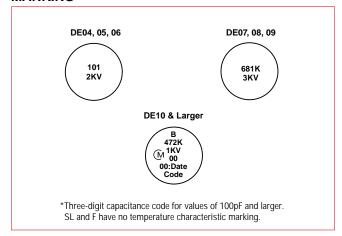
PART NUMBERING SYSTEM



TYPICAL TEMPERATURE CHARACTERISTICS



MARKING*



LEADED CAPACITORS, NETWORKS & HV CAPACITORS MEDIUM VOLTAGE CAPACITORS 1kV to 6kVDC E.I.A. CLASS II & III



B CHARACTERISTIC (Similar to EIA Temperature Characteristic Y5P)

Part Number (□: optional lead code shown at the right)	
Part Number (□: optional lead code shown at the right)	
(☐: optional lead code shown at the right) DE0405□B101K1K DE0405□B21K1K DE0405□B331K1K SDE0605□B102K1K DE0605□B102K1K DE0605	0 0
DE0405□B151K1K	DODO Lead Spacing F: 7.5 Pitch of Component P: 30.0
DE0605□B681K1K 680 6 DE0605□B102K1K 1000 6 DE0805□B152K1K 1500 8	
DE0605□B102K1K 1000 0 DE0805□B152K1K 1500 8	_
DE0905□B222K1K 2200 9	
DE1005□B332K1K 3300 10 DE1207□B472K1K 4700 12 7.5	
DE1207□B472KIK 4700 12 7.5 — — — — — — — — — — — — — — — — — — —	-477
DE0405□B101K2K 100 DE0405□B151K2K 150 4.5 DE0405□B221K2K 220	
DE0505□B331K2K 330 5	
DE0605□B471K2K 470 6 5.0 No Code -1 -979	
DE0705□B681K2K 680 7 2	_
DE0805□B102K2K 1000 8	
DE0905□B152K2K 1500 9	
DE1005□B22K2K 2200 10 DE1207□B332K2K 3300 12 7.5	
DE1207□B332K2K 3300 12 7.5 DE1507□B472K2K 4700 15 -610	-477
DE0507□B151K3K 150 5 DE0507□B21K3K 220	777
DE0607□B331K3K 330 6	
<u>DE0707□B471K3K</u> 470 7 7.5 3.15 -620 -486	_
DE0807□B681K3K 680 8	
DE0907□B102K3K 1000 9 DE1107□B152K3K 1500 11	
DE1107□B152K3K 1500 11 DE1307□B222K3K 2200 13	
DE1507□B332K3K 3300 15 -610	-477
DE0910□B101K6K 100	
DE0910□B151K6K 150 9 DE0910□B221K6K 220 No Code DE0910□B331K6K 330 10.0 6.3 No Code — Pull Only —	_
DE1010□B471K6K 470 10	
DE1110 □ B681K6K 680 11	
DE1310□B102K6K 1000 13	
E CHARACTERISTIC (Similar to EIA Temperature Characteristic Y5U) *90	00 pcs. for KH type
DE0505□E102Z1K 1000 5	
DE0705□E22221K 2200 7 5.0 1 -69 -979 —	
DE0905□E472Z1K 4/00 9	_
DE1307□E103Z1K 10000 13 7.5 -620 — -486 DE0605□E102Z2K 1000 6 — -486	
DE000E□E22272V 2200 0 E 0 No Codo 1 070	
DE1105□E472Z2K 4700 11 2 No Code -1 -9/19 —	
DE1607□E103Z2K 10000 16 7.5 -610	-477
DE0707□E102Z3K 1000 7	
DE1007□E22273K 2200 10 7.5 3.15 -620 -486	
DE1307□E472Z3K 4700 13 DE1310□E132Z4K 1000 11	
DE1110□E102Z6K 1000 11 10.0 6.3 Bulk Only — —	
DE1510 E222Z6K 2200 15 Section 15 Section 2200 15 Section 2200 Section	

F CHARACTERISTIC (Similar to EIA Temperature Characteristic Y5V)

						☐: Lead Configuration/Lead Code						
B . N .					Straight Long	Straight Short	Double Crimp	Taping* [†]				
Part Number (: optional lead code shown at the right)	Nominal Capacitance (pF)	Max. Body Diameter D (mm)	Lead Spacing F (mm)	Rated Voltage (kVDC)				Lead Spacing F: 5.0 Pitch of Component P: 12.7	Lead Spacing F: 7.5 Pitch of Component P: 15.0			
DE0605□F222Z1K	2200	6							_			
DE0705□F472Z1K	4700	7	5.0	1			-69					
DE1005□F103Z1K	10000	10						-979				
DE0505□F102Z2K	1000	5			No Code	-1		-117				
DE0705□F222Z2K	2200	7	5.0	2			_					
DE0905□F472Z2K	4700	9		2			_					
DE1207□F103Z2K	10000	12	7.5					_	-486			

All "No Code" bulk versions standard through authorized Murata Electronics Distributors. 1See page 64 for specifications.





LEADED CAPACITORS, NETWORKS & HV CAPACITORS MEDIUM VOLTAGE CAPACITORS 1kV to 6kVDC E.I.A. CLASS II & III–SPECIFICATIONS & TEST METHODS DE Series

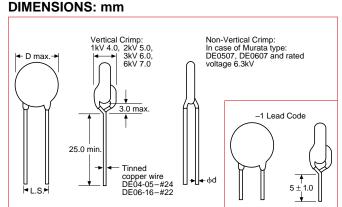
	ш		Specificat	ion	Tool Mathed		
Item			Temperature Compensating	High Dielectric Constant	Test Method		
1	Operating Tempe	rature Range	-25 to +85°C	-25 to +85°C	The connections about he was a state of 2000 at 111 d. 10 0111		
2	Capacitance Q		Within the specified tolerance.	Within the specified tolerance.	The capacitance shall be measured at 20°C with 1 ± 0.2kHz (SL: 1 ± 0.2MHz) and 5V(r.m.s.) max.		
Dissipation Factor (D.F.)		r (D.F.)	SL $C \ge 30pF: Q \ge 1000$ $C < 30pF: Q \ge 400 + 20C^1$	B, E D.F. ≤ 2.5% F D.F. ≤ 5.0%	Same condition as capacitance.		
4	Insulation Resistance (I.R.)	Between lead wires	10000M ohms min.	10000M ohms min.	The insulation resistance shall be measured with 500 \pm 50VDC within 60 \pm 5 sec. of charging.		
5	Dielectric Strength	Between lead wires	No failure.	No failure.	The capacitors shall not be damaged when DC voltage of 200% of the rated voltage is applied between the lead wires for 1 to 5 sec. (Charge/discharge current ≤50mA)		
		Body Insulation	No failure.	No failure.	The capacitor is placed in the container with metal balls of diameter 1mm so that each lead wire, short-circuited, is kept approximately 2mm off the balls as shown in the figure, and DC voltage of 1.3kV is applied for 1 to 5 sec. between capacitor lead wires and small metals. (Charge/discharge current ≤50mA).		
6	6 Temperature Characteristic		T.C. Temp. Coefficient SL +350 to -1000ppm/°C	T.C. Cap. Change B within ±10% E within ±55% F within ±30%	The capacitance measurement shall be made at each step specified in table. Capacitance change from the value of step 3 shall not exceed the limit specified.		
					condition ² for 24 ± 2 hours before initial measurements (B, E, F).		
7	Vibration Resistance	Appearance Capacitance Change	No marked defect. Within the specified tolerance.	No marked defect. Within the specified tolerance.	The capacitor shall firmly be soldered to the supporting lead wire and vibration which is 10 to 55Hz in the vibration frequency range, 1.5mm in total amplitude, and about 1 minute in the rate of vibration change		
		Q. D.F.	SL C ≥ 30pF: Q ≥ 1000 C < 30pF: Q ≥ 400 + 20C ¹	B, E D.F. ≤ 2.5% F D.F. ≤ 5.0%	from 10Hz to 55Hz and back to 10Hz is applied for a total of 6 hours 2 hours each in 3 mutually perpendicular directions.		
8	Soldering	Appearance	No marked defect.	No marked defect.	The lead wire shall be immersed into the melted solder of 350 \pm 10°C		
	Effect	Capacitance Change	SL within ±2.5%	B within ±5% E within ±15% F within ±20%	(body of ϕ 5 and under: 270 ± 5°C) up to about 1.5 to 2mm from the main body for 3.5 ± 0.5 sec. (body of ϕ 5 and under: 5 ± 0.5 sec.). Pre-treatment Capacitor shall be stored at 85 ± 2°C for 1 hour, then placed at room		
		Dielectric Strength (between lead wires)	Pass the item No. 5.	Pass the item No. 5.	condition ² for 24 ± 2 hours before initial measurements (B, E, F). Post-treatment Capacitor shall be stored for 1 to 2 hours at room condition ² (SL). Capacitor shall be stored for 24 ± 2 hours at room condition ² (B, E, F).		
9	Humidity	Appearance	No marked defect.	No marked defect.	Set the capacitor for 500 $^{+24}_{-0}$ hours at 40 ± 2°C in 90 to 95% humidity.		
	(Under Steady State)	Capacitance Change	SL within ±5%	B within ±10% E within ±20% F within ±30%	Pre-treatment Capacitor shall be stored at 85 ± 2°C for 1 hour, then placed at room condition ² for 24 ± 2 hours before initial measurements (B, E, F). Post-treatment		
		Q. D.F.	SL C ≥ 30pF: Q ≥ 350 C < 30pF: Q ≥ 275 + 5/2C ¹	B, E D.F. ≤ 5.0% F D.F. ≤ 7.5%	Capacitor shall be stored for 1 to 2 hours at room condition ² .		
10	11	I.R.	1000M ohms min.	1000M ohms min.	Apply the rated voltage for 500 $^{+24}_{-0}$ hours at 40 ± 2°C in 90 to 95%		
10	Humidity Loading	Appearance Capacitance Change	No marked defect. SL within ±7.5%	No marked defect. B within ±10% E within ±20%	Apply the fated voltage for 500 ±6 hours at 40 ± 2 € in 90 to 95% humidity. (Charge/discharge current ≤50mA). Pre-treatment Capacitor shall be stored at 85 ± 2°C for 1 hour, then placed at room		
		Q.	C1 C≥30pF: Q≥200	F within ±30% B, E D.F. ≤ 5.0%	condition ² for 24 ± 2 hours before initial measurements (B, E, F). Post-treatment		
		D.F.	SL $C < 30pF: Q \ge 100 + \frac{10}{3}C^{1}$ 500M ohms min.	F D.F. ≤ 7.5% 500M ohms min.	Capacitor shall be stored for 1 to 2 hours at room condition ² (SL). Capacitor shall be stored at 85 ± 2°C for 1 hour, then placed at room condition ² for 24 ± 2 hours (B, E, F).		
11	Life	Appearance	No marked defect.	No marked defect.	Apply a DC voltage of 150% of the rated voltage for 1000 ⁺⁴⁸ ₋₀ hours at		
		Capacitance Change	SL within ±3%	B within ±10% E within ±20%	85 ± 2°C. (Charge/discharge current ≤50mA). Pre-treatment Capacitor shall be stored at 85 ± 2°C for 1 hour, then placed at room		
		Q. D.F.	SL $C \ge 30pF: Q \ge 350$ $C < 30pF: Q \ge 275 + \frac{5}{2}C^{1}$	F within ±30% B, E D.F. ≤ 4.0% F D.F. ≤ 7.5%	condition ² for 24 ± 2 hours before initial measurements (B, E, F). Post-treatment Capacitor shall be stored for 1 to 2 hours at room condition ² (SL).		
		I.R.	2000M ohms min.	2000M ohms min.	Capacitor shall be stored at $85 \pm 2^{\circ}$ C for 1 hour, then placed at room condition ² for 24 ± 2 hours (B, E, F).		
12	Strength of Lead	Pull	Lead wire shall not cut off. Capacitor shall not be broken.	2000M OHIIS HIIII.	As in figure, fix the body of capacitor, apply a tensile weight gradually to each lead wire in the radial direction of capacitor up to 10N (1.0kgf) 5N (0.51kgf) for lead diameter ϕ 0.5, and		
		Bending			keep it for 10 ± 1 sec. Each lead wire shall be subjected to 5N (0.51kgf) 2.5N (0.25kgf) for lead diameter ϕ 0.5 weight and then a 90° bend, at the point of egress, in one direction, return to original position, and then a 90° bend in the opposite direction at the rate of one bend in 2 to 3 seconds.		
13	Solderability of L		Lead wire shall be soldered with undirection over 3/4 of the circumfere	ential direction.	The lead wire of a capacitor shall be dipped into a methanol solution of 25wt% rosin and then into molten solder of $235 \pm 5^{\circ}$ C for 2 ± 0.5 seconds. In both cases the depth of dipping is up to about 1.5 to 2mm from the root of lead wires.		

LEADED CAPACITORS, NETWORKS & HV CAPACITORS HIGH TEMPERATURE CAPACITORS

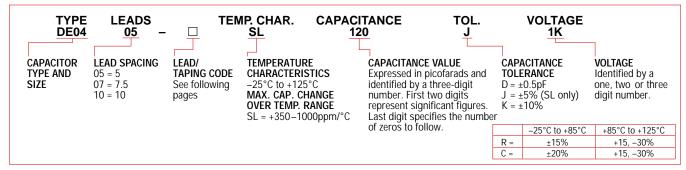
250V to 3kVDC E.I.A. CLASS I & II



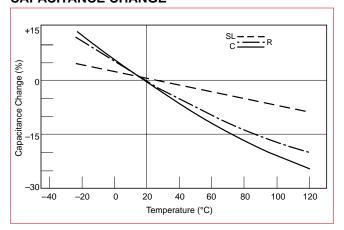




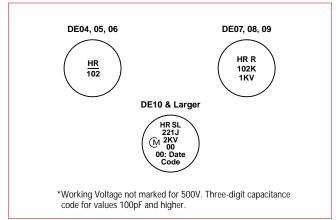
PART NUMBERING SYSTEM



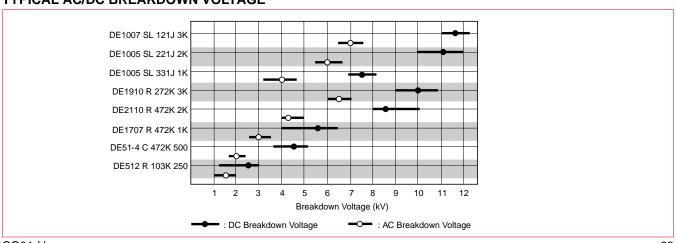
TYPICAL TEMPERATURE VS. **CAPACITANCE CHANGE**



MARKING*



TYPICAL AC/DC BREAKDOWN VOLTAGE



LEADED CAPACITORS, NETWORKS & HV CAPACITORS HIGH TEMPERATURE CAPACITORS 250V to 3kVDC E.I.A. CLASS I & II



SL CHARACTERISTIC

SL CHARACT						. [: Lead Configu	ration/Lead Cod	e	
					Straight	Straight	Double Crimp		Taping* [†]	
Part Number	Nominal	Max.	Lead	Rated	Long	Short	Crimp	99	00	0.0
(□: optional lead code shown	Capacitance	Body Diameter	Spacing	Voltage	()				p To Ta	<u> </u>
at the right)	(pF)	D (mm)	F (mm)	(kVDC)	M	M	\sim	Lead Spacing F: 5.0	Lead Spacing F: 7.5	Lead Spacing F: 7.5
							()	Pitch of Component	Pitch of Component	Pitch of Component
					1 1		' '	P: 12.7	P: 15.0	P: 30.0
DE0405□SL100D1K DE0405□SL120J1K	10 12									
DE0405□SL150J1K	15 18									
DE0405□SL180J1K DE0405□SL220J1K	22	4.5								
DE0405□SL270J1K DE0405□SL330J1K	22 27 33									
DE0405□SL390J1K	39									
DE0405□SL470J1K DE0505□SL560J1K	. 47 56	F								
DE0505□SL680J1K	68	5	5.0	1			-69	-979	_	
DE0605□SL820J1K DE0605□SL101J1K	82 100	6								
DE0605□SL121J1K DE0705□SL151J1K	120 150	_								
DE0705□SL181J1K	180	7								
DE0805□SL221J1K DE0905□SL271J1K	220 270	8 9								
DE1005□SL331J1K DE1005□SL391J1K	330 390	10								
DE1105□SL471J1K	470	11								_
DE1207□SL561J1K DE0405□SL100D2K	560 10	12	7.5			-1	-620	_	-486	
DE0405□SL120J2K	12									
DE0405□SL150J2K DE0405□SL180J2K	15 18	4.5								
DE0405□SL220J2K DE0405□SL270J2K	22 27									
DE0405□SL330J2K	33									
DE0505□SL390J2K DE0605□SL470J2K	39 47	5	5.0				-69	-979	_	
DE0605 SL560J2K	56	6		.0	2 No Code					
DE0605□SL680J2K DE0705□SL820J2K	. 68 82	7		2						
DE0705□SL101J2K DE0805□SL121J2K	100 120									
DE0805□SL151J2K	150	8								
DE0905□SL181J2K DE1005□SL221J2K	180 220	9 10								
DE1107□SL271J2K	270	11							404	
DE1207□SL331J2K DE1307□SL391J2K	330 390	12 13	7.5				-620		-486	
DE1407□SL471J2K DE1507□SL561J2K	470 560	14 15							_	-477
DE0507□SL100D3K	10	10								
DE0507□SL120J3K DE0507□SL150J3K	12 15	5								
DE0507□SL180J3K	18	-								
DE0507□SL220J3K DE0607□SL270J3K	22 27									
DE0607□SL330J3K DE0607□SL390J3K	33 39	6						_		
DE0707 SL470J3K	47	7	7.5	0.45					-486	_
DE0707□SL560J3K DE0807□SL680J3K	. 56 68			3.15		_	_			
DE0807□SL820J3K DE0907□SL101J3K	82 100	8								
DE1007□SL121J3K	120	10								
DE1107□SL151J3K DE1107□SL181J3K	150 180	11								
DE1207□SL221J3K	220	12								
DE1407□SL271J3K DE1507□SL331J3K	270 330	14 15							_	-477
		_								1,,,

R CHARACTERISTIC (250V)

*900 pcs. for KH type

				☐: Lead Configuration/Lead Code						
5					Straight Long	Straight Short	Double Crimp	Taping* [†]		
Part Number (: optional lead code shown at the right)	Nominal Capacitance (pF)	Max. Body Diameter D (mm)	Lead Spacing F (mm)	Rated Voltage (VDC)		9		Lead Spacing F: 5.0 Pitch of Component P: 12.7		
DE506□R221K250	220									
DE506 R331K250	330									
DE506□R471K250	470	6								
DE506□R681K250	680									
DE506 R102K250	1000									
DE507 R152K250	1500	7	5.0	250	No Code	–1	-69	-979		
DE508 R222K250	2200	8								
DE509 R332K250	3300	9								
DE510□R472K250	4700	10								
DE512□R682K250	6800	12								

LEADED CAPACITORS, NETWORKS & HV CAPACITORS HIGH TEMPERATURE CAPACITORS 250V to 3kVDC E.I.A. CLASS I & II



R CHARACTERISTIC (1 to 3 15kV)

R CHARACTE	KISTIC (1	to 3.15K	/)							
							☐: Lead Configu	ration/Lead Cod	е	
Part Number		Max.		.	Straight Long	Straight Short	Double Crimp		Taping* [†]	
(: optional lead code shown at the right)	Nominal Capacitance (pF)	Body Diameter D (mm)	Lead Spacing F (mm)	Rated Voltage (kVDC)		\bigcap		Lead Spacing F: 5.0 Pitch of Component P: 12.7	Lead Spacing F: 7.5 Pitch of Component P: 15.0	DOOD Lead Spacing F: 7.5 Pitch of Component P: 30.0
DE0705□R221K1K DE0705□R331K1K DE0705□R471K1K DE0805□R681K1K DE0905□R102K1K	220 330 470 680 1000	7 8 9	5.0	1			-69	-979	_	_
DE1105□R152K1K	1500	11							407	
DE1310□R222K1K DE1510□R332K1K	2200 3300	13 15	10.0				-610		-486	
DE1710 R472K1K	4700	17	10.0				-010	_	_	-477
DE0707□R221K2K DE0707□R271K2K	220 270	7								
DE0807□R331K2K DE0807□R391K2K	330 390	8		2		-1				
DE0907□R471K2K DE0907□R561K2K	470 560	9								_
DE1007□R681K2K DE1107□R821K2K	680 820	10 11	7.5				-620		-486	
DE1107□R621K2K DE1207□R102K2K DE1207□R122K2K DE1207□R152K2K	1000 1200 1500	12								
DE1407□R182K2K	1800	14			No Code					
DE1507□R222K2K	2200	15		-						-477
DE1707□R272K2K	2700	17					-810	-		
DE1910□R332K2K	3300	19								
DE2010□R392K2K	3900	20	10.0						_	
DE2110□R472K2K	4700	21						_		
DE0707□R151K3K DE0707□R181K3K DE0707□R221K3K DE0707□R271K3K	150 180 220 270	7								
DE0807□R331K3K	330	8								_
DE0907□R391K3K	390	9							-486	
DE1007□R471K3K DE1007□R561K3K	470 560	10	7.5	3.15		_	_			
DE1107□R681K3K	680	11								
DE1207 R821K3K	820	12								
DE1307□R102K3K	1000 1200	13 14								
DE1407□R122K3K DE1507□R152K3K	1500	15								
DE1607 R182K3K	1800	16							_	-477
DE1707□R162K3K	2200	17							_	
DE1707□R222K3K DE1910□R272K3K	2700	19	10.0							_
PL1710-R212R3R	2/00	17	10.0				1			

C CHARACTERISTIC

*900 pcs. for KH type

						□: Lead Configu	ration/Lead Code				
David Nameda au					Straight Long	Straight Short	Double Crimp	Taping* [↑]			
Part Number (□: optional lead code shown at the right)	Nominal Capacitance (pF)	Max. Body Diameter D (mm)	Lead Spacing F (mm)	Rated Voltage (VDC)		9		Lead Spacing F: 5.0 Pitch of Component P: 12.7			
DE50-6□C331K500 DE50-6□C471K500	330 470	6									
DE50-7 C681K500	680	7		F00	E00	EOO	E00				
DE50-8 C102K500	1000	8	5.0					500	500	500	EOO
DE50-9□C152K500	1500	9		500	NO CODE	-1					
DE51-0 C222K500	2200	10									
DE51-2 C332K500	3300	12									
DE51-4 C472K500	4700	14	10.0				-610	_			

[†]See page 64 for specifications.

*900 pcs. for KH type



LEADED CAPACITORS, NETWORKS & HV CAPACITORS HIGH TEMPERATURE CAPACITORS 250V to 3kVDC E.I.A. CLASS I & II—SPECIFICATIONS & TEST METHODS DE Series

	Item		•	fication			Test Method			
1	Operating Temper	rature Range	-25 to +125°C				_			
2	Capacitance		Within the specified tolerance.		. 2 . 40.4 (5 . 5 .	5017	The capacitance shall be measured at 20°C with 1 ± 0.2kHz (SL: 1 ± 0.2MHz) and 5V(r.m.s.) max.			
3	Q Dissipation Factor (D.F.)		$ \begin{array}{lll} C \geq 30 p F\colon Q \geq 1000 & D.F. \leq 0.4\% \ (R \ [250V]) \\ C < 30 p F\colon Q \geq 400 + 20 C^1 (SL) & D.F. \leq 0.2\% \ (R \ [1 \ to \ 3.15 kV]) \\ D.F. \leq 0.3\% \ (C) \\ \hline 10000M \ ohms \ min. & 1000M \ ohms \ min. \\ \end{array} $			to 3.15kV])				
4	Insulation Resistance (I.R.)		10000M ohms min. (SL, R [1 to 3.15kV], C)		M ohms min 50V])	l.	The insulation resistance shall be measured with 500 ± 50VDC (R [250V]: 100 ± 15V) within 60 ± 5 sec. of charging.			
5	Dielectric Strength	Between lead wires	No failure.				The capacitors shall not be damaged when DC voltage of 200% of the rated voltage (in case of rated voltage: 1 to 3.15kV) or DC voltage of 250% of the ratec voltage (in case of rated voltage: 250V, 500V) is applied between the lead wires for 1 to 5 sec. (Charge/discharge current ≤50mA)			
		Body Insulation No failure.				The capacitor is placed in the container with metal balls of diameter 1mm so that each lead wire, short-circuited, is kept approximately 2mm off the balls as shown in the figure, and AC voltage of 1250V is applied for 1 to 5 sec. between capacitor lead wires and small metals. (Charge/discharge current ≤50mA)				
6	Temperature Cha	racteristic	T.C. Temp. Coefficient	Temp.		hange	The capacitance measurement shall be made at each step specified in table.			
			SL +350 to -1000ppm/°C	Range -25 to	C within	R within	Capacitance change from the value of step 3 shall not exceed the limit specified. Char\Step			
				+85°C	±20%	±15%	SL — $20 \pm 2^{\circ}C = 85 \pm 2^{\circ}C/125 \pm 2^{\circ}C = 20 \pm 2^{\circ}C$ C, R $20 \pm 2^{\circ}C = -25 \pm 3^{\circ}C = 20 \pm 2^{\circ}C = 85 \pm 2^{\circ}C/125 \pm 2^{\circ}C = 20 \pm 2^{\circ}C$			
				+85 to +125°C	within	1 +15%	Pre-treatment: Capacitor shall be stored at 125 ± 3°C for 1 hour, then placed at room condition² for 24 ± 2 hours before initial measurements (R, C).			
7	Temperature	Appearance	No marked defect.		arked defect		The capacitor shall be introduced into the test chamber, and shall be exposed to			
	Cycling	Capacitance Change	Within ±5% (SL)	Withi	n ±10% (R,	C)	the temperature conditions of steps 1 to 4 as shown in table at 5 cycles. Step Temp. (°C) Time (min.) Step Temp. (°C) Time (min.)			
		Q	C ≥ 30pF: Q ≥ 350	D.F. ≤	≤ 0.4% (R, C)	1 -25 ± 3 30 ± 3 +125 ± 3 30 ± 3			
		D.F.	$C < 30pF: Q \ge 275 + \frac{5}{2}C^{1}$ (SL)		•	,	2 room temp. 3 max. 4 room temp. 3 max. Pre-treatment: Capacitor shall be stored at 125 ± 3°C for 1 hour, then placed room condition² for 24 ± 2 hours before initial measurements (R, C).			
		I.R.	1000M ohms min.							
	Dielectric Strength		Pass the item No. 5.				Post-treatment: Capacitor shall be stored for 1 to 2 hours at room condition ² (SL). Capacitor shall be stored for 24 ± 2 hours at room condition ² (R, C).			
		(between lead wires)					Measurement Order: I.R., Dielectric Strength → Pre-treatment → Capacitance,			
		leau wiles)					D.F. → Temp. Cycling test → Post-treatment → Capacitance, D.F., I.R., Dielectric Strength (R [250V]).			
8	Vibration	Appearance	No marked defect.				The capacitor shall firmly be soldered to the supporting lead wire and vibration			
	Resistance	Capacitance Change	Within the specified tolerance.				which is 10 to 55Hz in the vibration frequency range, 1.5mm in total amplitude, and about 1 minute in the rate of vibration change from 10Hz to 55Hz and back			
		Q.	C ≥ 30pF: Q ≥ 1000	D.F. <	≤ 0.4% (R [2	50V1)	to 10Hz is applied for a total of 6 hours; 2 hours each in 3 mutually perpendicular directions.			
		D.F.	$C < 30pF: Q \ge 400 + 20C^{1}(SL)$	D.F. ≤	≤ 0.2% (R [1		perpendicular directions.			
9	Soldering	Appearance	No marked defect.	D.F. ≤	≤ 0.3% (C)		The lead wire shall be immersed into the melted solder of 350 ± 10°C up to			
•	Effect	Capacitance	Within ±2.5% (SL)	Withi	n ±10% (R,	C)	about 1.5 to 2mm from the main body for 3.5 \pm 0.5 sec. and the specified items			
		Change	D 11 11 N E				shall be measured after leaving for 24 ± 2 hours. Pre-treatment: Capacitor shall be stored at 125 ± 3°C for 1 hour, then placed room condition² for 24 ± 2 hours before initial measurements (R, C). Post-treatment: Capacitor shall be stored for 1 to 2 hours at room condition² (SL). Capacitor shall be stored for 24 ± 2 hours at room condition² (R, C).			
		Dielectric Strength	Pass the item No. 5.							
		(between								
		lead wires)					Measurement Order: Dielectric Strength → Pre-treatment → Capacitance → Soldering Effect test → Post-treatment → Capacitance, Dielectric Strength (R [250V]).			
10	Humidity	Appearance	No marked defect.				Set the capacitor for 500 $^{+24}_{0}$ hours at 40 \pm 2°C in 90 to 95% humidity.			
	(Under Steady State)	Capacitance	Within ±5% (SL)	Withi	n ±10% (R,	C)	Pre-treatment: Capacitor shall be stored at $125 \pm 3^{\circ}$ C for 1 hour, then placed at room condition ² for 24 ± 2 hours before initial measurements (R, C).			
	Jicauy Jiaic)	Change Q	C ≥ 30pF: Q ≥ 350	DF <	≤ 0.4% (R, C)	Post-treatment: Capacitor shall be stored for 1 to 2 hours at room condition ² .			
		D.F.	$C < 30pF: Q \ge 275 + \frac{5}{2}C^{1}$ (SL)		- 3. 170 (11, 0	,	Measurement Order: I.R. → Pre-treatment → Capacitance, D.F. → Humidity test → Post-treatment → Capacitance, D.F., I.R. (R [250V]).			
		I.R.	1000M ohms min.				(Charge/discharge current ≤50mA).			
11	Life	Appearance Capacitance	No marked defect.	\ \/!+ b:	n ±10% (R,	C)	Apply a DC voltage of 200% of the rated voltage (in case of rated voltage: 250V, 500V) or DC voltage of 150% of the rated voltage (in case of rated voltage:			
		Change	Within ±3% (SL)	VVILITI	π±1070 (K,	·)	1 to 3.15kV) for 1000 ⁺⁴⁸ ₋₀ hours at 125 ± 2°C.			
		Q D.F.	$C \ge 30pF: Q \ge 350$ $C < 30pF: Q \ge 275 + \frac{5}{2}C^{1}$ (SL)	D.F. ≤	≤ 0.4% (R, C)	Pre-treatment: Capacitor shall be stored at $125 \pm 3^{\circ}$ C for 1 hour, then placed at room condition ² for 24 ± 2 hours before initial measurements (R, C). Post-treatment: Capacitor shall be stored for 1 to 2 hours at room condition ²			
		I.R.	2000M ohms min.	1000	M ohms min	l.	(SL). Capacitor shall be stored at 125 ± 3°C for 1 hour, then placed at room			
			(SL, R [1 to 3.15kV], C)	(R [2	50V])		condition ² for 24 ± 2 hours (R, C). Measurement Order: I.R. → Pre-treatment → Capacitance, D.F. → Life test →			
							I.R. ³ \rightarrow Post-treatment \rightarrow Capacitance, D.F. (R [250V]).			
12	Strength	Pull	Lead wire shall not cut off				(Charge/discharge current ≤50mA). As in figure, fix the body of capacitor, apply a tensile weight gradually ///////////////////////////////////			
12	of Lead	. un	Lead wire shall not cut off. Capacitor shall not be broken.				As in figure, fix the body of capacitor, apply a tensile weight gradually to each lead wire in the radial direction of capacitor up to 10N (1.0kgf) and keep it for 10 ± 1 sec.			
		Bending	-				Each lead wire shall be subjected to 5N (0.51kqf) weight and then a 90° bend, at			
		g					the point of egress, in one direction, return to original position, and then a 90°			
13	Solderability of L	eads	Lead wire shall be soldered wi	th unifor	m coating or	the axial	bend in the opposite direction at the rate of one bend in 2 to 3 seconds. The lead wire of a capacitor shall be dipped into a methanol solution of 25wt.			
13	3 Solderability of Leads		direction over ³ / ₄ of the circum			i tilo axiai	rosin and then into molten solder of 235 ± 5°C for 2 ± 0.5 seconds. In both cases the depth of dipping is up to about 1.5 to 2mm from the root of lead wir			

^{1°}C" expresses nominal capacitance value (pF). 2"room condition" temperature: 15 to 35°C; humidity: 45 to 75%; atmospheric pressure: 860 to 1060hPa.

³The measurement of I.R. will be held in 12 to 24 hours after Life test.